ECH8690

ON Semiconductor®

Power MOSFET

60V, 4.7A, 55mΩ -60V, -3.5A, 94mΩ Complementary Dual ECH8

http://onsemi.com

Features

- On-State Resistance Nch:RDS(on)1= $42m\Omega(typ.)$
- Pch:RDS(on)1=73m Ω (typ.)
- 4V drive • Nch+Pch MOSFET

- Protection diode in
- Halogen free compliance

Specifications

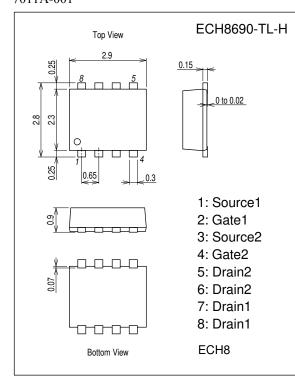
Absolute Maximum Ratings at Ta = 25°C

Parameter	Symbol	Conditions	N-channel	P-channel	Unit	
Drain to Source Voltage	V _{DSS}		60	-60	V	
Gate to Source Voltage	V _{GSS}		±20	±20	V	
Drain Current (DC)	ID		4.7	-3.5	Α	
Drain Current (Pulse)	I _{DP}	PW≤10μs, duty cycle≤1%	30	-30	Α	
Allowable Power Dissipation	PD	When mounted on ceramic substrate (1200mm ² ×0.8mm)1unit		1.5		
Total Dissipation	PT	When mounted on ceramic substrate (1200mm ² ×0.8mm)		1.8		
Channel Temperature	Tch			150		
Storage Temperature	Tstg			- 55 to +150		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Package Dimensions

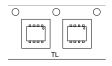
unit: mm (typ) 7011A-001



Ordering & Package Information

Device	Package	Shipping	note
ECH8690-TL-H	ECH8	3000 pcs. / reel	Pb-Free and Halogen Free

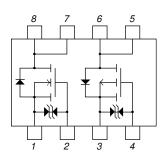
Packing Type: TL



Marking



Electrical Connection



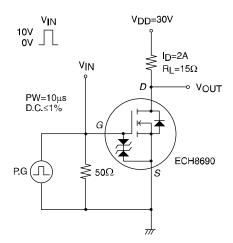
ECH8690

Electrical Characteristics at Ta = 25°C

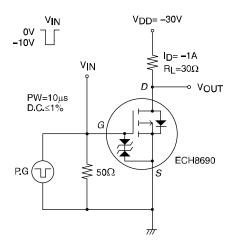
Parameter	Symbol	Conditions		Ratings		
i aidilicici	Gymbol	Conditions	min	typ	max	Unit
[N-channel]	<u>, </u>					
Drain to Source Breakdown Voltage	V(BR)DSS	I _D =1mA, V _{GS} =0V	60			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =60V, V _{GS} =0V			1	μΑ
Gate to Source Leakage Current	IGSS	$V_{GS}=\pm 16V$, $V_{DS}=0V$			±10	μΑ
Cutoff Voltage	V _{GS} (off)	$V_{DS}=10V$, $I_{D}=1mA$	1.2		2.6	V
Forward Transfer Admittance	yfs	$V_{DS}=10V$, $I_{D}=2A$		4.2		S
Static Drain to Source On-State Resistance	R _{DS} (on)1	I _D =2A, V _{GS} =10V		42	55	mΩ
	R _{DS} (on)2	I _D =1A, V _{GS} =4.5V		53	74	mΩ
	R _{DS} (on)3	I _D =1A, V _{GS} =4V		61	85	mΩ
Input Capacitance	Ciss			955		pF
Output Capacitance	Coss	V _{DS} =20V, f=1MHz		58		pF
Reverse Transfer Capacitance	Crss			45		pF
Turn-ON Delay Time	t _d (on)			7		ns
Rise Time	t _r	See specified Test Circuit.		8.4		ns
Turn-OFF Delay Time	t _d (off)	dee speemed rest officials.		76		ns
Fall Time	tf			23		ns
Total Gate Charge	Qg			18		nC
Gate to Source Charge	Qgs	V _{DS} =30V, V _{GS} =10V, I _D =4.7A		3		nC
Gate to Drain "Miller" Charge	Qgd			2.8		nC
Diode Forward Voltage	V _{SD}	I _S =4.7A, V _{GS} =0V		0.82	1.2	V
[P-channel]	•	•				
Drain to Source Breakdown Voltage	V(BR)DSS	I _D =-1mA, V _G S=0V	-60			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =-60V, V _{GS} =0V			-1	μА
Gate to Source Leakage Current	IGSS	V _{GS} =±16V, V _{DS} =0V			±10	μА
Cutoff Voltage	V _{GS} (off)	V _{DS} =-10V, I _D =-1mA	-1.2		-2.6	V
Forward Transfer Admittance	yfs	V _{DS} =-10V, I _D =-1.5A		3.4		S
	R _{DS} (on)1	I _D =-1A, V _{GS} =-10V		73	94	mΩ
Static Drain to Source On-State Resistance	R _{DS} (on)2	I _D =-0.5A, V _G S=-4.5V		97	135	mΩ
nesisiance	R _{DS} (on)3	I _D =-0.5A, V _G S=-4V		108	153	mΩ
Input Capacitance	Ciss			790		pF
Output Capacitance	Coss	V _{DS} =-20V, f=1MHz		63		pF
Reverse Transfer Capacitance	Crss	7		45		pF
Turn-ON Delay Time	t _d (on)			10		ns
Rise Time	t _r	See specified Test Circuit.		8.8		ns
Turn-OFF Delay Time	t _d (off)			84		ns
Fall Time	tf	7		29		ns
Total Gate Charge	Qg			15		nC
Gate to Source Charge	Qgs	V _{DS} =-30V, V _{GS} =-10V, I _D =-3.5A		2.6		nC
Gate to Drain "Miller" Charge				2.2		nC
			1			

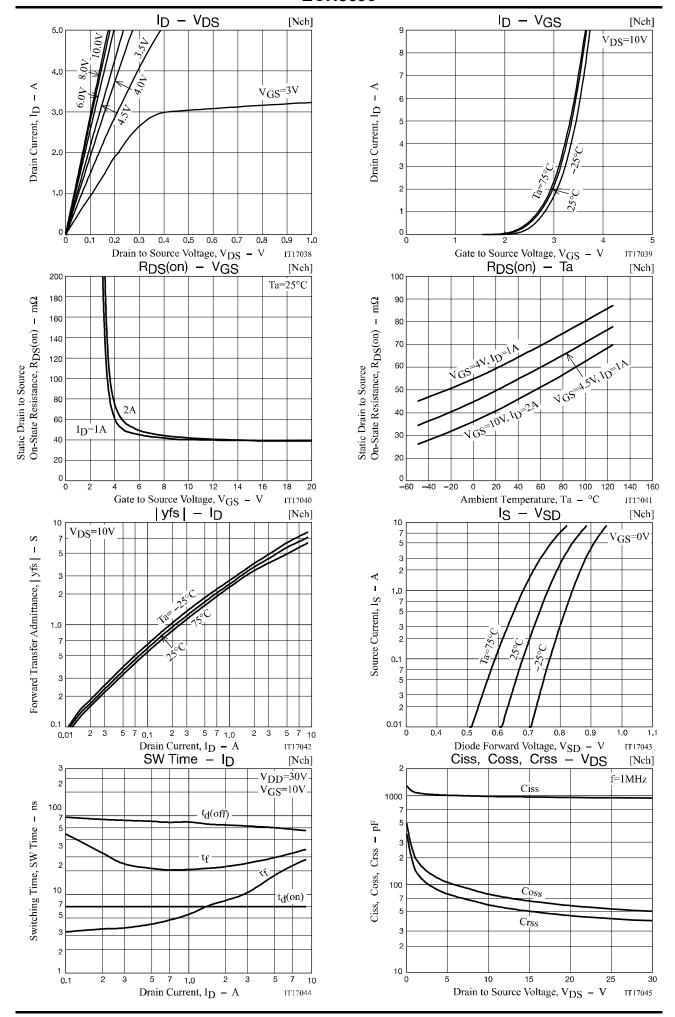
Switching Time Test Circuit

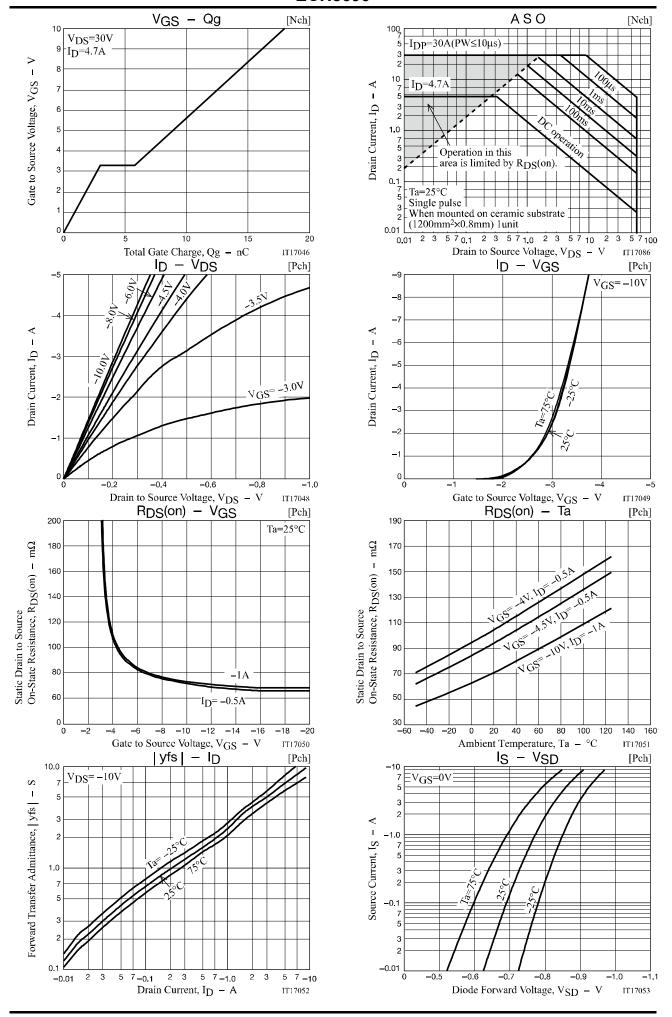
[N-channel]

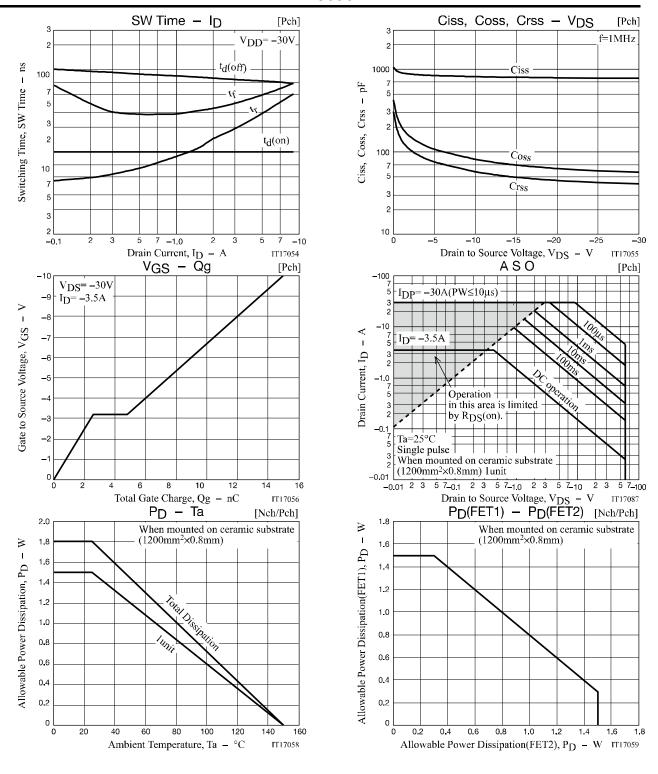


[P-channel]



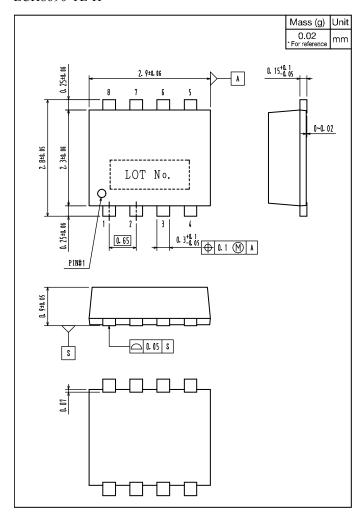




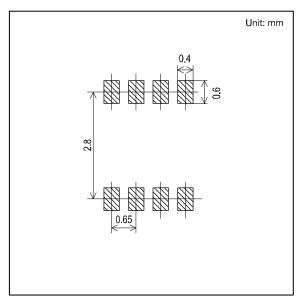


Outline Drawing

ECH8690-TL-H



Land Pattern Example



Note on usage: Since the ECH8690 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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